Compliance Sheet for Electrochemical Impedance Spectroscopy Setup for Solar Photovoltaic Devices सौर फोटोवोल्टिक उपकरणों के लिए विद्युत रासायनिक प्रतिबाधा स्पेक्ट्रोस्कोपी सेटअप के लिए तुलना पत्र

Here we are looking for a Potenstiostat Galvanostat Impedance Analyzer for the following applications:

- 1. I-V characteristics of thin films and semiconductor devices (like solar photovoltaic, diode etc.).
- 2. Impedance spectroscopy of semiconductor devices (like solar photovoltaic, diode etc.).

| S. | Particulars | S. | IPR's Requirement / Specifications | | Vendors' Specification |
|-------|---|-------|------------------------------------|----------------------------------|------------------------|
| No. | | No. | | T | |
| 1 | Power Amplifier | 1.1 | Compliance Voltage | ≥ ± 25 V | |
| 1 | | 1.2 | Maximum Current | ≥1 A | |
| 2 | Potentiostat Bandwidth | 2.1 | ≥ 5 MHz | | |
| Pote | ntiostatic Mode | | | | |
| | Voltage Control | 3.1 | Applied DC Voltage Range | ± 10 V (selectable) | |
| 3 | | 3.2 | Applied DC Voltage Resolution | ≥ 16 bit | |
| | | 3.3 | Maximum DC voltage scan Rate | ≥ 100 V/sec | |
| | Current | 4.1 | Measured DC Current Range | 10nA to 1A | |
| 4 | Measurement | | | 9 decades (ranges) or more | |
| | | 4.2 | Measured DC Current resolution | ≥ 16 bit | |
| Galv | anostatic Mode | | | | |
| | Current Control 5.1 | 5.1 A | Applied DC Current Range | 10nA to 1A | |
| 5 | | | | 9 decades (ranges) or more | |
| | | 5.2 | Applied DC Current resolution | ≥ 16 bit | |
| 6 | Voltage | 6.1 | Measured DC Voltage Range | ± 10 V | |
| 0 | Measurement | 6.2 | Measured DC Voltage Resolution | ≥ 16 bit | |
| 7 | Leakage Current | 7.1 | ≤ 10 pA | | |
| | Or Input Bias Current | | | | |
| Elect | Electrochemical Impedance Spectroscopy (EIS) Mode | | | | |
| | Impedance (EIS | 8.1 | Mode | Potentiostatic and Galvanostatic | |
| 8 | mode) | 8.2 | Frequency Range | 10μHZ to ≥ 5MHz | |
| | | 8.3 | Frequency Resolution | 10 to 100 steps / decade | |

Vendors' seal and Sign

| 1 | I | 8.4 | Maximum Input Voltage range | ±10V | | |
|----|-------------------|------|---|---|--|--|
| | | 8.5 | Input Impedance | ≥ 1 Tohm in parallel with ≤ 10 pF | | |
| | | 8.6 | Applied AC amplitude | ≤ 1mV rms to ≥ 100 mV rms | | |
| | | 8.7 | AC voltage resolution | ≤ 0.5mV | | |
| | | 8.8 | Swipe Mode | Linear and Logarithmic | | |
| 9 | Cell Connections | 9.1 | Cell / Electrode Connections | 2, 3, 4 (WE, S, CE, RE) and ground electrode | | |
| | cen connections | 3.1 | End Connectors with cables | Following types of end connectors are required: | | |
| | | | End Connectors with capies | Crocodile Clips | | |
| | | | | 2. Male type BNC connection | | |
| | | | | (both for each connection) | | |
| | | 9.2 | | 3. Proper required connectors to be given for | | |
| | | | | converting connections from 4 to 2 probe | | |
| | | | | connections | | |
| | | | | (Note: we have probe setup with panel | | |
| | | | | mounted female BNC connections) | | |
| 10 | Data Acquisition | 10.1 | A/D converter (ADC) | ≥ 16 bit | | |
| | | 10.2 | D/A converter (DAC) | ≥ 16 bit | | |
| 11 | Interface to PC | 11.1 | , , | r connection between PC to instrument and with | | |
| | | | - | matching end connectors at both ends) | | |
| 12 | Dummy Cell | 12.1 | External Dummy Cell should be provided with the instrument for testing purpose | | | |
| | Power Requirement | 13.1 | Total Maximum Power | ≤ 1000 W | | |
| 13 | | 13.2 | Mains Input | 230V, 50Hz, Single Phase AC, Indian Standards | | |
| | | 13.3 | Connection | 3 pin top plug as per Indian Standards | | |
| | PC (Computer | 14.1 | | minimum 21 inch LED monitor OR a laptop with | | |
| | Specification) | 112 | minimum of 15 inch LED screen sho | · | | |
| | 14. | | Licensed windows 10 Professional should be provided with computer Microprocessor: i5-10th generation or higher version | | | |
| | | 14.3 | Hard Disk : ≥ 500 GB | n or nigher version | | |
| 14 | | 14.4 | appropriate required USB ports for | connection of instrument | | |
| | | 14.5 | USB mouse (in case of desktop) | connection of instrument | | |
| | | 14.6 | USB Key board (in case of desktop) | | | |
| | | 14.7 | One spare USB port and One spare | | | |
| | | 14.8 | | · | | |
| | | 14.5 | All necessary power and other cables and connections should be provided. | | | |

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|----|--------------------|------|--|--|
| | Software | 15.1 | software for all measurement, fitting, analysis etc. should be provided | |
| | | 15.2 | software should have proper user friendly graphic environment for plotting, overlay, | |
| | | 13.2 | fitting, analysis, simulation etc. | |
| 15 | | 15.3 | Control of all the hardware should be done through software | |
| | | 15.4 | Data Analysis - Capability of Real Time fit, equivalent circuit fitting, Simulation etc. | |
| | | 15.5 | Compatible to Windows 10 operating system | |
| | | 15.6 | License - Lifetime | |
| | Type of | 16.1 | Cyclic Voltammetry | |
| 16 | Measurements | 16.2 | Electrochemical Impedance Spectroscopy (EIS) | |
| 10 | | 16.3 | Linear Sweep Voltammetry | |
| | | 16.4 | Chrono Techniques (Voltammetry + Amperometry) | |
| | Measurements of | 17.1 | Current - DC bias Voltage (I-V) | |
| | Solar Photovoltaic | 17.2 | Capacitance - DC bias Voltage (C-V) with various frequencies | |
| | Device | 17.3 | Mott Schottky analysis (1/C ² -V) with various frequencies | |
| | | 17.4 | Capacitance - Frequency (C-f) with various biasing voltage | |
| 17 | | 17.5 | Imaginary Impedance - Real Impedance (Z _{im} - Z _{re}) with various frequencies (i.e. | |
| | | 17.5 | Nyquist Plot / Cole-Cole plot) | |
| | | 17.6 | Impedance - Frequency (Z-f) (i.e. Bode Plot) | |
| | | 17.7 | Current - Time (I-t) | |
| | | 17.8 | Voltage - Time (V-t) | |
| 18 | Warranty and | 18.1 | Minimum One Year warranty from the date of installation | |
| 10 | Service | 18.2 | Supplier should provide onsite warranty and service support. | |
| | Scope of Vendor | 19.1 | Fabricate / Supply & Testing of setup | |
| 19 | | 19.2 | Installation and commissioning at FCIPT, IPR, | |
| 13 | | 13.2 | Demonstration on IPR's thin film solar photovoltaic device sample | |
| | | 19.3 | Operation Training to IPR personnel at IPR site (FCIPT campus) | |
| 20 | Delivery Time | 20.1 | 12 weeks from the date of P.O. | |
| 21 | Installation | 21.1 | 2 weeks from the date of delivery | |

| | Factory Acceptance | | Following test should be conducted using external dummy cell available with the | |
|----|--------------------|------|--|--|
| | Test | | instrument and results of the test should be sent to IPR for approval before dispatch: | |
| | | | 1. DC measurement: | |
| | | | a. Connect the instrument to the resister in the range of 1 MOhm (as per available | |
| | | | in dummy cell) in the dummy cell and swipe the voltage from -10V to +10V (in | |
| | | | equidistance 100 points) and record the current. Data should be sent in excel | |
| | | | file format with screen shot of the measurement for approval of dispatch. | |
| | | | b. Connect the instrument to the resister in the range of 1 KOhm (as per available | |
| | | | in dummy cell) in the dummy cell and swipe the voltage from -10V to +10V (in | |
| 22 | | 22.1 | equidistance 100 points) and record the current. Data should be sent in excel | |
| | | | file format with screen shot of the measurement for approval of dispatch. | |
| | | | 2. EIS measurement: | |
| | | | a. Connect the instrument to the Randle circuit of the dummy cell and measure | |
| | | | the impedance (i.e. Nyquist Plot) for 10μHz to 1MHz frequency range and | |
| | | | calculate the value of circuit components (i.e. series resistance (100-1000 Ohm | |
| | | | as per available in dummy cell), parallel resistance (1-10 KOhm as per available | |
| | | | in dummy cell) and capacitance (~1μF as per available in dummy cell)) by fitting | |
| | | | the measured data using the software. Data should be sent in excel file format | |
| | | | with screen shot of the measurement for approval of dispatch. | |

| | Acceptance Criteria | | Testing will be performed by vendor's engineer at IPR in presence of IPR's technical | |
|----|---------------------|--|---|--|
| | (Testing at IPR) | | person. | |
| | | | Following tests will be done for resistivity measurement using I-V characteristics: | |
| | | | 1. I-V test for the range of instrument with different resistors in potentiostatic and | |
| | | | galvanostatic mode (2-probe measurements) | |
| | | | a. 1 Ohm or less to 10 Ohm for lower voltage (1V range) and higher current | |
| | | | range (1 A range) | |
| | | | b. 100 Ohm – 10 KOhm for mid voltage (5 V range) and mid current range | |
| | | | (10 mA range) | |
| | | | c. 1 MOhm for higher voltage (10 V range) and lower current (10 nA range) | |
| | | | 2. Measurement of Sheet resistance of thin film using 4-probe setup to test the | |
| | | | working in four probe mode. (galvanostatic mode) (Note: four probe setup and | |
| | | 23.1 | | |
| | | | metallic thin film will be provided by the IPR with four banana lugs to connect to | |
| 23 | | | the instrument) | |
| | | | 3. Following tests will be performed at external dummy cell and IPR provided | |
| | | | photovoltaic cell (CZTS absorber based thin film solar cell) in impedance (EIS) | |
| | | | mode: | |
| | | | a. I-V characteristics of the cell (as per PN junction) | |
| | | | b. Mott Schottky analysis $(1/C^2 - V)$ where voltage is applied -5 to +5 V and | |
| | | | Capacitance is measured with various frequencies 100 Hz, 1KHz, 10KHz, | |
| | | | 100KHz, 1MHz, 5MHz | |
| | | | c. Capacitance - Frequency (C-f) where frequency is varied from 100Hz to | |
| | | | 5MHz in steps decades with various biasing voltage(-5V to +5V) | |
| | | | d. Imaginary Impedance - Real Impedance (Z _{im} - Z _{re}) with various frequencies | |
| | | (from 10μHz to 5 MHz with variation of 10 to 100 points in every decade) | | |
| | | (i.e. Nyquist Plot / Cole-Cole plot) | | |
| | | e. Impedance - Frequency (Z-f) (i.e. Bode Plot) for the same range as | | |
| | | | mentioned above. | |

Any Other information / feature etc. need to be mentioned: